

Notice of References Cited	Application/Control No. 10/795,817	Applicant(s)/Patent Under Reexamination VENKATESH ET AL	
	Examiner Sam K. Ahn	Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0012270	01-2003	Zhou et al.	375/150
*	B	US-2004/0170238	09-2004	Matsuyama et al.	375/343
*	C	US-2004/0240486	12-2004	Venkatesh et al.	370/537
*	D	US-2006/0133456	06-2006	Ettorre et al.	375/148
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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